


<b>Search Notes</b>  	<b>Application/Control No.</b>  10799139	<b>Applicant(s)/Patent Under Reexamination</b>  DUFF ET AL.
	<b>Examiner</b>  Flores, Leon	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	316, 376	4/9/2007	LF
375	354, 355	9/29/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	4/13/2007	LF
Checked for double patenting.	4/9/2007	LF
Search in IEEE	4/9/2007	LF
Consulted with SPE David Payne in regards to the amendment.	10/10/2007	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner